Dual DPDT Ultra-Low R_{ON} Switch

The NLAS3799 is an ultra–low R_{ON} DPDT and a 0.5 Ω R_{ON} DPDT analog switch. This device is designed for low operating voltage, high current switching of speaker output and earpiece for cellphone applications. It can switch a balanced stereo output. The NLAS3799 can handle a balanced microphone/speaker/ring–tone generator in a monophone mode. The device contains a break–before–make (BBM) feature.

Features

- Single Supply Operation 1.65 to 3.6 V V_{CC}
- Maximum Breakdown Voltage: 4.6 V
- Low Static Power
- NLAS3799 Interfaces with 2.8 V Chipset NLAS3799L Interfaces with 1.8 V Chipset
- These are Pb-Free Devices*

Typical Applications

- Cell Phone Speaker/Microphone Switching
- Ringtone-Chip/Amplifier Switching
- Four Unbalanced (Single-Ended) Switches
- Stereo Balanced (Push-Pull) Switching

Important Information

• ESD Protection:

HBM (Human Body Model) > 8000 V MM (Machine Model) > 400 V

- Continuous Current Rating Through each Switch ±300 mA
- Conforms to: JEDEC MO-220, Issue H, Variation VEED-6
- Package: 1.8 x 2.6 x 0.75 mm μQFN-16 Pb-Free



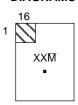
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http://onsemi.com

MARKING DIAGRAMS



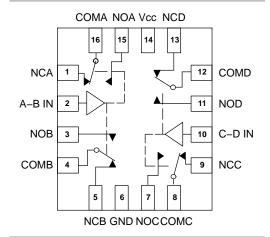
μQFN-16 CASE 488AP



XX = Specific Device CodeAR = NLAS3799AT = NLAS3799L

M = Date Code/Aseembly Location

= Pb-Free Package



ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 10 of this data sheet.

^{*}For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

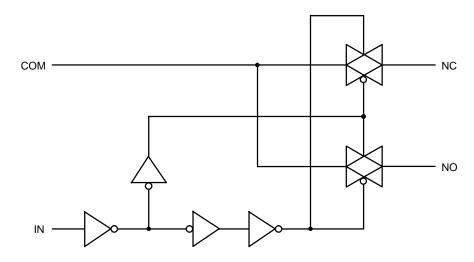


Figure 1. Input Equivalent Circuit

PIN DESCRIPTION

QFN PIN #	Symbol	Name and Function			
1, 3, 5, 7, 9, 11, 13, 15	NO A-D, NC A-D	Independent Channels			
2, 10	A-B IN, C-D IN	Controls			
4, 8, 12, 16	COM A-D	Common Channels			
6	GND	Ground (V)			
14	V _{CC}	Positive Supply Voltage			

TRUTH TABLE

IN	NO	NC		
Н	ON	OFF*		
L	OFF*	ON		

^{*}High impedance.

MAXIMUM RATINGS

Symbol	Parameter	Value	Unit
V _{CC}	Positive DC Supply Voltage	-0.5 to +4.6	V
V _{IS}	Analog Input Voltage (V _{NO} , V _{NC} , or V _{COM})	$-0.5 \le V_{IS} \le V_{CC} + 0.5$	V
V _{IN}	Digital Select Input Voltage	$-0.5 \le V_{IN} \le +V_{CC}$	V
I _{anl1}	Continuous DC Current from COM to NC/NO	±300	mA
I _{anl-pk1}	Peak Current from COM to NC/NO, 10 Duty Cycle (Note 1)	±500	mA
I _{clmp}	Continuous DC Current into COM/NO/NC with Respect to V _{CC} or GND	±100	mA

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

1. Defined as 10% ON, 90% OFF Duty Cycle.

RECOMMENDED OPERATING CONDITIONS

Symbol	Parameter	Min	Max	Unit
V _{CC}	DC Supply Voltage	1.65	3.6	V
V _{IN}	Digital Select Input Voltage	GND	V _{CC}	V
V _{IS}	Analog Input Voltage (NC, NO, COM)	GND	V _{CC}	V
T _A	Operating Temperature Range	-40	+85	°C
t _r , t _f	Input Rise or Fall Time, IN $ V_{CC} = 1.6 \text{ V} - 2.7 \text{ V} $ $ V_{CC} = 3.0 \text{ V} - 3.6 \text{ V} $		20 10	ns/V

NLAS3799 DC CHARACTERISTICS - DIGITAL SECTION (Voltages Referenced to GND)

				Guara	anteed Limit	
Symbol	Parameter	Condition	V _{CC}	25°C	–40°C to +85°C	Unit
V _{IH}	Minimum High-Level Input Voltage, Select Inputs		3.0 3.6	1.4 1.7	1.4 1.7	V
V _{IL}	Maximum Low–Level Input Voltage, Select Inputs		3.0 3.6	0.5 0.5	0.5 0.5	V
I _{IN}	Maximum Input Leakage Current, Select Inputs	V _{IN} = V _{CC} or GND	3.6	±0.1	±1.0	μΑ
I _{OFF}	Power Off Leakage Current	V _{IN} = 3.6 V or GND	0	±0.5	±2.0	μΑ
I _{CC}	Maximum Quiescent Supply Current (Note 2)	Select and V _{IS} = V _{CC} or GND	1.65 to 3.6	±1.0	±2.0	μΑ

^{2.} Guaranteed by design. Resistance measurements do not include test circuit or package resistance.

NLAS3799 DC ELECTRICAL CHARACTERISTICS - ANALOG SECTION

				Gua	ranteed	Maximun	n Limit	
		25°C -40°C to +6	25°C		25°C -40°C to		o +85°C	
Symbol	Parameter	Condition	V _{CC}	Min	Max	Min	Max	Unit
R _{ON}	NC/NO On–Resistance (Note 3)	$V_{IN} = V_{IL}$ or $V_{IN} = V_{IH}$ $V_{IS} = GND$ to V_{CC} $I_{IN}I = 100$ mA	3.0 3.6		0.5 0.4		0.5 0.4	Ω
R _{FLAT}	NC/NO On–Resistance Flatness (Notes 3 and 4)	I _{COM} = 100 mA V _{IS} = 0 to V _{CC}	3.0 3.6		0.15 0.15		0.15 0.15	Ω
ΔR_{ON}	On–Resistance Match Between Channels (Notes 3 and 5)	V _{IS} = 1.5 V; I _{COM} = 100 mA V _{IS} = 1.8 V; I _{COM} = 100 mA	3.0 3.6		0.05 0.05		0.05 0.05	Ω
I _{NC(OFF)} I _{NO(OFF)}	NC or NO Off Leakage Current (Note 3)	$ \begin{array}{c} V_{IN} = V_{IL} \text{ or } V_{IH} \\ V_{NO} \text{ or } V_{NC} = 0.3 \text{ V} \\ V_{COM} = 3.3 \text{ V} \end{array} $	3.6	-10	10	-100	100	nA
I _{COM(ON)}	COM ON Leakage Current (Note 3)	$\begin{aligned} &V_{IN} = V_{IL} \text{ or } V_{IH} \\ &V_{NO} \text{ 0.3 V or 3.3 V with} \\ &V_{NC} \text{ floating or} \\ &V_{NC} \text{ 0.3 V or 3.3 V with} \\ &V_{NO} \text{ floating} \\ &V_{COM} = \text{ 0.3 V or 3.3 V} \end{aligned}$	3.6	-10	10	-100	100	nA

Guaranteed by design. Resistance measurements do not include test circuit or package resistance.
 Flatness is defined as the difference between the maximum and minimum value of On–resistance as measured over the specified analog

^{5.} $\Delta R_{ON} = R_{ON(MAX)} - R_{ON(MIN)}$ between nS2 or nS1.

NLAS3799L DC CHARACTERISTICS - DIGITAL SECTION (Voltages Referenced to GND)

				Guaranteed Limit		
Symbol	Parameter	Condition	V _{CC}	25°C	–40 to +85°C	Unit
V _{IH}	Minimum High–Level Input Voltage, Select Inputs		3.0 3.6	1.2 1.3	1.2 1.3	V
V _{IL}	Maximum Low-Level Input Voltage, Select Inputs		3.0 3.6	0.5 0.5	0.5 0.5	V
I _{IN}	Maximum Input Leakage Current, Select Inputs	V _{IN} = V _{CC} or GND	3.6	±0.1	±1.0	μΑ
I _{OFF}	Power Off Leakage Current	V _{IN} = 3.6 V or GND	0	±0.5	±2.0	μΑ
Icc	Maximum Quiescent Supply Current (Note 6)	Select and V _{IS} = V _{CC} or GND	1.65 to 3.6	±10	±20	μΑ

^{6.} Guaranteed by design. Resistance measurements do not include test circuit or package resistance.

NLAS3799L DC ELECTRICAL CHARACTERISTICS - ANALOG SECTION

				Gua	ranteed	Maximur	n Limit	
				25°C		-40°C to +85°C		
Symbol	Parameter	Condition	V _{CC}	Min	Max	Min	Max	Unit
R _{ON}	NC/NO On–Resistance (Note 7)	$V_{IN} = V_{IL}$ or $V_{IN} = V_{IH}$ $V_{IS} = GND$ to V_{CC} $I_{IN}I = 100$ mA	3.0 3.6		0.5 0.5		0.5 0.5	Ω
R _{FLAT}	NC/NO On–Resistance Flatness (Notes 7 and 8)	$I_{COM} = 100 \text{ mA}$ $V_{IS} = 0 \text{ to } V_{CC}$	3.0 3.6		0.15 0.15		0.15 0.15	Ω
ΔR_{ON}	On-Resistance Match Between Channels (Notes 7 and 9)	V _{IS} = 1.5 V; I _{COM} = 100 mA V _{IS} = 1.8 V; I _{COM} = 100 mA	3.0 3.6		0.05 0.05		0.05 0.05	Ω
I _{NC(OFF)} I _{NO(OFF)}	NC or NO Off Leakage Current (Note 7)	$\begin{array}{c} V_{IN} = V_{IL} \text{ or } V_{IH} \\ V_{NO} \text{ or } V_{NC} = 0.3 \text{ V} \\ V_{COM} = 3.3 \text{ V} \end{array}$	3.6	-10	10	-100	100	nA
I _{COM(ON)}	COM ON Leakage Current (Note 7)	$\begin{aligned} &V_{IN} = V_{IL} \text{ or } V_{IH} \\ &V_{NO} \text{ 0.3 V or 3.3 V with} \\ &V_{NC} \text{ floating or} \\ &V_{NC} \text{ 0.3 V or 3.3 V with} \\ &V_{NO} \text{ floating} \\ &V_{COM} = \text{ 0.3 V or 3.3 V} \end{aligned}$	3.6	-10	10	-100	100	nA

^{7.} Guaranteed by design. Resistance measurements do not include test circuit or package resistance.

^{8.} Flatness is defined as the difference between the maximum and minimum value of On–resistance as measured over the specified analog signal ranges.

^{9.} $\Delta \ddot{R}_{ON} = R_{ON(MAX)}^{\circ} - R_{ON(MIN)}$ between NC1 and NC2 or between NO1 and NO2.

NLAS3799/NLAS3799L AC ELECTRICAL CHARACTERISTICS (Input t_r = t_f = 3.0 ns)

					Gua	rantee	d Maxi	mum l	_imit	
			V _{CC}	V _{IS}	Via			_	°C to 5°C	
Symbol	Parameter	Test Conditions	(V)	(V)	Min	Тур*	Max	Min	Max	Unit
t _{ON}	Turn-On Time	$R_L = 50 \Omega$, $C_L = 35 pF$ (Figures 3 and 4)	2.3 – 3.6	1.5			50		60	ns
t _{OFF}	Turn-Off Time	$R_L = 50 \Omega$, $C_L = 35 pF$ (Figures 3 and 4)	2.3 – 3.6	1.5			30		40	ns
t _{BBM}	Minimum Break-Before-Make Time	$V_{IS} = 3.0$ $R_L = 50 \Omega$, $C_L = 35 pF$ (Figure 2)	3.0	1.5	2	15				ns

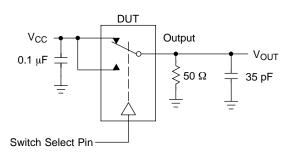
		Typical @ 25, V _{CC} = 3.6 V	
C _{IN}	Control Pin Input Capacitance	3.0	pF
C _{SN}	SN Port Capacitance	72	pF
C_D	D Port Capacitance When Switch is Enabled	220	pF

^{*}Typical Characteristics are at 25°C.

ADDITIONAL APPLICATION CHARACTERISTICS (Voltages Referenced to GND Unless Noted)

			V _{CC}	25°C	
Symbol	Parameter	Condition	(V)	Typical	Unit
BW	Maximum On-Channel -3 dB Bandwidth or Minimum Frequency Response (Figure 9)	V _{IN} centered between V _{CC} and GND (Figure 5)	1.65 – 3.6	19	MHz
V _{ONL}	Maximum Feed-through On Loss	V_{IN} = 0 dBm @ 100 kHz to 50 MHz V_{IN} centered between V_{CC} and GND (Figure 5)	1.65 – 3.6	-0.06	dB
V _{ISO}	Off–Channel Isolation	$f = 100 \text{ kHz}$; $V_{IS} = 1 \text{ V RMS}$; $C_L = 5.0 \text{ pF}$ V_{IN} centered between V_{CC} and GND(Figure 5)	1.65 – 3.6	-69	dB
Q	Charge Injection Select Input to Common I/O (Figure 8)	$V_{IN} = V_{CC \text{ to}}$ GND, $R_{IS} = 0 \Omega$, $C_L = 1.0 \text{ nF}$ Q = $C_L \times \Delta V_{OUT}$ (Figure 6)	1.65 – 3.6	42	pC
THD	Total Harmonic Distortion THD + Noise (Figure 7)	F_{IS} = 20 Hz to 20 kHz, R_L = R_{gen} = 600 Ω,C_L = 50 pF V_{IS} = 2 V_{PP}	3.0	0.11	%
VCT	Channel-to-Channel Crosstalk (Figure 10)	f = 100 kHz; V_{IS} = 1.0 V RMS, C_L = 5.0 pF, R_L = 50 Ω V_{IN} centered between V_{CC} and GND (Figure 5)	1.65 – 3.6	-90	dB

^{10.} Off-Channel Isolation = 20log10 (V_{COM}/V_{NO}), V_{COM} = output, V_{NO} = input to off switch.



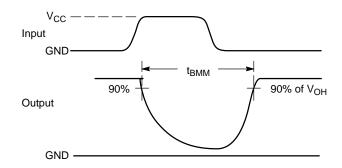
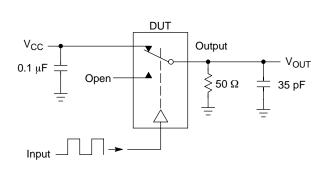


Figure 2. t_{BBM} (Time Break-Before-Make)



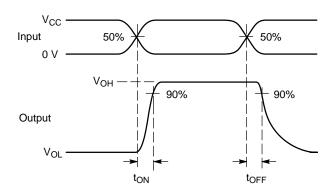
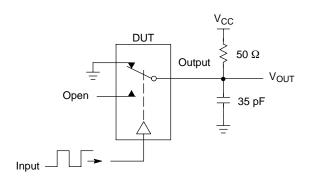


Figure 3. t_{ON}/t_{OFF}



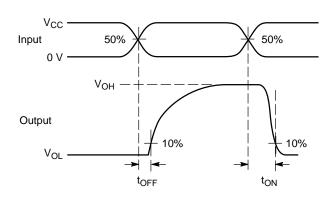
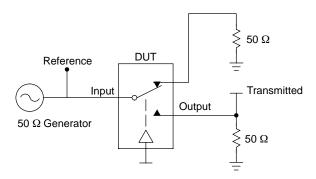


Figure 4. t_{ON}/t_{OFF}



Channel switch control/s test socket is normalized. Off isolation is measured across an off channel. On loss is the bandwidth of an On switch. V_{ISO} , Bandwidth and V_{ONL} are independent of the input signal direction.

$$\begin{split} &V_{ISO} = \text{Off Channel Isolation} = 20 \text{ Log} \left(\frac{V_{OUT}}{V_{IN}} \right) \text{ } \text{ for } V_{IN} \text{ at } 100 \text{ kHz} \\ &V_{ONL} = \text{On Channel Loss} = 20 \text{ Log} \left(\frac{V_{OUT}}{V_{IN}} \right) \text{ } \text{ for } V_{IN} \text{ at } 100 \text{ kHz to } 50 \text{ MHz} \end{split}$$

Bandwidth (BW) = the frequency 3 dB below V_{ONL}

 V_{CT} = Use V_{ISO} setup and test to all other switch analog input/outputs terminated with 50 Ω

Figure 5. Off Channel Isolation/On Channel Loss (BW)/Crosstalk (On Channel to Off Channel)/V_{ONL}

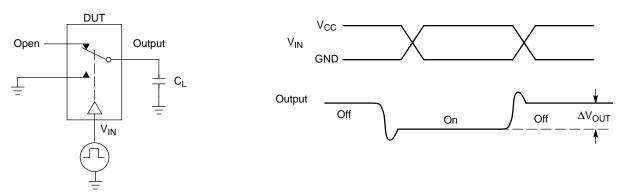
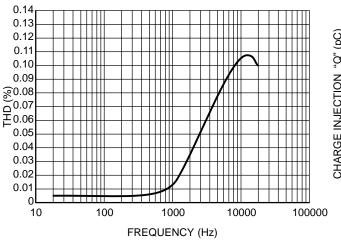


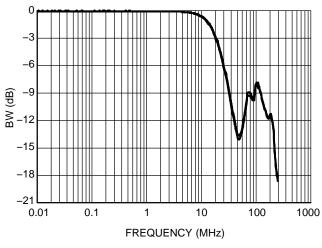
Figure 6. Charge Injection: (Q)



-5 CHARGE INJECTION "Q" (pC) -10 -15 -20 -25 -30 -35 -40 -45 3.5 0 0.5 1.5 2.5 3 $V_{IN}(V)$

Figure 7. Total Harmonic Distortion vs. Frequency

Figure 8. Charge Injection @ V_{CC} = 3.0 V



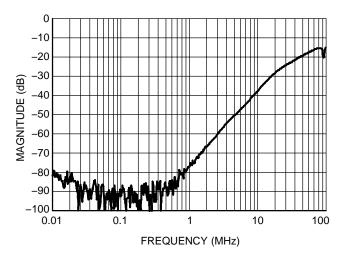
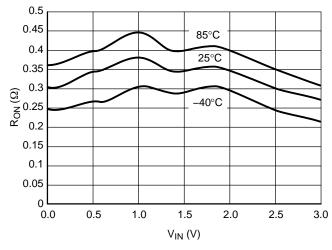


Figure 9. Bandwidth vs. Frequency

Figure 10. Cross-Talk vs. Frequency



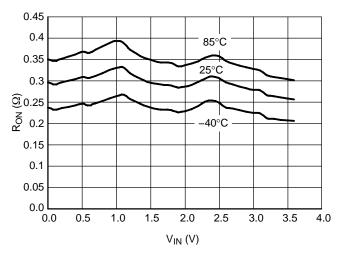


Figure 11. R_{ON} vs. V_{IN} vs. Temperature @ V_{CC} = 3.0 V

Figure 12. R_{ON} vs. V_{IN} vs. Temperature @ V_{CC} = 3.6 V

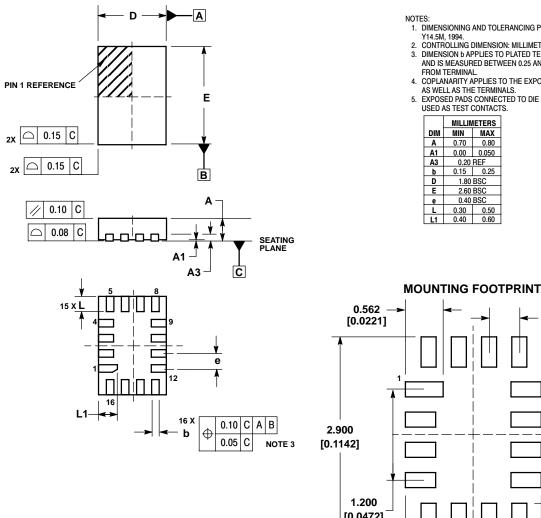
DEVICE ORDERING INFORMATION

		Devi	ce Nomenc	lature			
Device Order Number	Circuit Indicator	Technology	Device Function	Package Suffix	Tape & Reel Suffix	Package Type	Tape & Reel Size [†]
NLAS3799MNR2G	NL	AS	3799	MN	R2	μQFN (Pb–Free)	3000 / Tape & Reel
NLAS3799LMNR2G	NL	AS	3799L	MN	R2	μQFN (Pb–Free)	3000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

QFN-16 (1.8 x 2.6 x 0.75 mm) CASE 488AP-01 **ISSUE O**

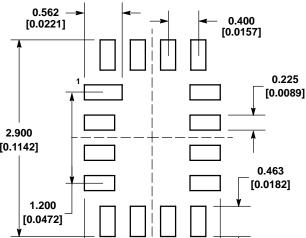


NOTES

- DIMENSIONING AND TOLERANCING PER ASME
- Y14.5M, 1994.
 2. CONTROLLING DIMENSION: MILLIMETERS
 3. DIMENSION 5 APPLIES TO PLATED TERMINAL
 AND IS MEASURED BETWEEN 0.25 AND 0.30 MM
- FROM TERMINAL.
 COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

 EXPOSED PADS CONNECTED TO DIE FLAG.
- USED AS TEST CONTACTS.

	MILLIMETERS	
DIM	MIN	MAX
Α	0.70	0.80
A1	0.00	0.050
A3	0.20 REF	
b	0.15	0.25
D	1.80 BSC	
E	2.60 BSC	
е	0.40 BSC	
L	0.30	0.50
L1	0.40	0.60



2.100 [0.0827]

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